

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10520310	VAN DER MARK ET AL.
Examiner	Art Unit	
HENOK G HEYI	2627	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
searched class 369/13.13, 13.17, 13.18, 13.19 and 13.33 - text search only (see search history printout) and also consulted primary Tan Dinh.	11/29/2007	HH
Updated search.	07/24/2008	HH
Conducted more search on EAST.	12/05/2008	HH
Updated search.	06/05/2009	HH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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